Schematics and Land Patterns(mm)

SD6D40Q1 TYPE

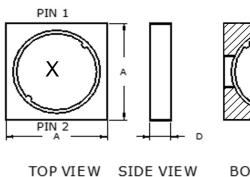
FEATURE

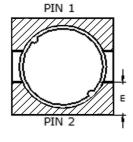
- 1. Low DC resistance
- 2. Magnetic Shielding type

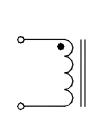
Applications

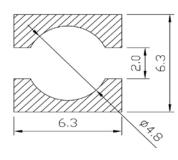
- 1. Automotive power controller and others portable
- 2. AEC-Q200 Qualified.
- 3. Same as Maruwa MIB6040M series

Shape and Dimension

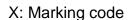








BOTTOM VIEW



A=6.00±0.30 m/m; D=4.00m/m Max; E=2.20m/m Ref.

6.7 Property of the state of th

Note: Recommend 2 patterns size. All patterns are fitness.

Specification

P/N	L	Marking	DCR	DCR	Isat	Irms
	(µH)	Code	(Ω)Max	(Ω)Typ.	(A)	(A)
SD6D40Q1-4R7N	4.7±30%	Α	0.029	0.022	4.43	4.58
SD6D40Q1-6R8N	6.8±30%	В	0.036	0.027	3.55	4.11
SD6D40Q1-100M	10±20%	С	0.041	0.034	3.17	3.56
SD6D40Q1-150M	15±20%	D	0.069	0.057	2.78	2.89
SD6D40Q1-220M	22±20%	Е	0.120	0.093	1.94	2.09
SD6D40Q1-330M	33±20%	F	0.160	0.130	1.52	1.75
SD6D40Q1-101M	100±20%	G	0.350	0.290	1.02	1.21

Note1. Measurement frequency of Inductance value: at 100KHz, 0.25V

Note2. Measurement ambient temperature of L, DCR and IDC : at 25°C

Note3. Isat: DC current at which the inductance drops 30%(typ) from its value without current

Note4. Irms: Average current for 40°C temperature rise from 25°C ambient(typical)

Note5. Packing Quantity: 1000pcs/reel

GENERAL CHARACTERISTICS

- Operating temperature range: -40 TO + 125°C (Includes temperature when the coil is heated)
- 2. High temperature exposure(storage) refer MIL-STD-202 Method 108: 1000 hrs at rated operating temperature(e.g. 125°C). Part can be stored for 1000 hrs @125°C. Unpowered. Measurement at 24±4 hours after test conclusion.
- 3. Temperature cycling refer JESD22 Method JA-104: 1000 cycles(-40 TO + 125℃). Measurement at 24±4 hours after test conclusion. 30 min maximum dwell time at each temp. extreme. 1 min. maximum transition time.
- 4. Biased Humidity refer MIL-STD-202 Method 103: 1000 hours 85°C/85%RH. Unpowered. Measurement at 24±4 hours after test conclusion.
- 5. Operational Life refer MIL-PRF-27: 1000 hrs. at 125 °C tested. Measurement at 24±4 hours after test conclusion.
- 6. External Visual refer MIL-STD-883 Method 2009: Inspect device construction, marking and workmanship.
- 7. Physical Dimension refer JESD22 Method JB-100: Verify physical dimensions to the applicable device detail specification.
- 8. Resistance to Solvents refer MIL-STD-202 Method 215: Add aqueous wash chemical OKEM clean or equivalent.
- 9. Mechanical Shock refer MIL-STD-202 Method 213: Figure 1 of Method 213. Condition C.
- 10. Vibration refer MIL-STD-202 Method 204: 5g;s for 20 minutes, 12 cycles each of 3 orientations. Test from 10-2000 Hz.
- 11. Resistance to soldering Heat refer MIL-STD-202 Method 210: Condition B No pre-heat of samples. Single wave solder-procedure 2 for SMD and procedure 1 for leaded with solder within 1.5mm of device body.
- 12. ESD refer AEC-Q200-002 or ISO/DIS 10605: Direct contact discharge 2kV.
- 13. Solderability refer J-STD-002: For both Leaded & SMD. Magnification 50X. Conditions: Leaded, Method A@235℃, category 3; SMD, a)Method B, 4hrs@125℃ dry heat @235℃, b)Method B@215℃ category 3., c)Method D category 3@260℃
- 14. Electrical Characterization refer spec: Show Min, Max Mean and Standard deviation at room from Min and Max temperature.
- 15. Flammability refer UL-94: V-0 or V-1 Acceptable.
- 16. Board Flex refer AEC-Q200-005: 60 sec minimum holding time.
- 17. Terminal Strength(SMD) refer AEC-Q200-006
- 18. Reflow profile recommend:

